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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/764,352	MASUDA ET AL.	
Examiner	Art Unit	
Chih-Ching Chow	2191	

	SEARCHED			
Class	Subclass	· Date	Examiner	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
717	174	6/12/2007	СС	
717	168	6/12/2007	СС	
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
EAST: Text Search	6/5/2007	СС
EAST: Interference Search	6/12/2007	СС
EAST: Inventor Search	6/12/2007	СС
Consulted with SPE Ms. Wei Zhen for allowance	6/5/2007	СС
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